

### Amendments to the Claims:

This listing of claims will replace all prior version, and listings, of claims in the application.

#### Listing of Claims:

1 (currently amended) A method for obtaining an optimal reflectivity value for complex multilayer stacks, comprising:

- (a) generating a model of a multilayer stack and parameterizing each layer by a thickness and an index of refraction;
- (b) allowing a user to input values for the parameters and to designate a plurality of the parameters as independent variables;
- (c) calculating an extrema for a cost function of reflectivity  $R$  using the input parameter values;
- (d) calculating sensitivity values  $S$  for the extrema ~~points~~; and
- (e) obtaining ~~an~~ the optimal reflectivity value by calculating a cost function  $R + S$  using the plurality of independent variables at once.

2 (original) The method of claim 1 wherein step (e) further includes the step of: calculating the cost function as  $R + \alpha \cdot S$ , where  $\alpha$  is a weighted parameter.

3 (original) The method of claim 1 wherein step (a) further includes the step of: providing the multilayer stack with  $N$  layers, where a top layer comprises a top ambient resist layer followed by one or more layers of materials that are patterned over a substrate layer.

4 (original) The method of claim 2 wherein step (a) further includes the step of: providing the index of refraction to include a real and an imaginary number.

5 (original) The method of claim 4 wherein step (a) further includes the step of: providing a  $j^{\text{th}}$  layer with thickness  $d_j$ , and a complex index of refraction  $n_j = n_j - i k_j$ .

6 (original) The method of claim 5 wherein step (a) further includes the step of: providing the ambient and substrate with complex indexes of refraction:  $n_0 = n_0 - i k_0$  and  $n_{N+1} = n_{N+1} - i k_{N+1}$ , respectively.

7 (original) The method of claim 6 wherein step (a) further includes the step of: defining reflectivity at an interface between two layers as a cost function, wherein the reflectivity  $R_j$  at a  $j^{\text{th}}$  interface (between the  $(j - 1)^{\text{th}}$  and  $j^{\text{th}}$  layers) is a function of  $3(N - j + 1) + 4$  parameters, which are ;  $n_{j-1}, n_j \dots n_N, n_{N+1}; k_{j-1}, k_j \dots k_N, k_{N+1}; d_j, d_{j+1} \dots d_N$ .

8 (currently amended) The method of claim 1 wherein step (b) further includes the step of: allowing the user to enter values for the thickness and the complex indexes of refraction ( $n$  and  $k$ ) for each layer, including a current starting point, a minimum values, and a maximum value for the thickness and the complex indexes of refraction for each layer.

9 (currently amended) The method of claim 8 wherein step (b) further includes the step of: allowing the user to ~~choose which of the parameters will be independent variables and to enter step values for the parameters designated as independent variables~~, wherein those parameters that are not designated as varying independent variables are fixed.

10 (original) The method of claim 1 wherein step (e) further includes the step of: defining the sensitivity as  $S = (\text{Max } R - \text{Min } R)$  for all varied parameters.

11 (currently amended) A computer-readable medium containing program instructions for obtaining an optimal reflectivity value for complex multilayer stacks, the instructions for:

- (a) generating a model of a multilayer stack and parameterizing each layer by a thickness and an index of refraction;
- (b) allowing a user to input values for the parameters and to designate a plurality of parameters as independent variables;
- (c) calculating an extrema for a cost function of reflectivity  $R$  using the input parameter values;
- (d) calculating sensitivity values  $S$  for the extrema points; and
- (e) obtaining ~~an~~ the optimal reflectivity value by calculating a cost function  $R + S$  using the plurality of independent variables at once.

12 (original) The computer-readable medium of claim 11 wherein instruction (e) further includes the instruction of: calculating the cost function as  $R + \alpha S$ , where  $\alpha$  is a weighted parameter.

13 (original) The computer-readable medium of claim 11 wherein instruction (a) further includes the instruction of: providing the multilayer stack with  $N$  layers, where a top layer comprises a top ambient resist layer followed by one or more layers of materials that are patterned over a substrate layer.

14 (original) The computer-readable medium of claim 13 wherein instruction (a) further includes the instruction of: providing the index of refraction to include a real and an imaginary number.

15 (original) The computer-readable medium of claim 14 wherein instruction (a) further includes the instruction of: providing a  $j^{\text{th}}$  layer with thickness  $d_j$ , and a complex index of refraction  $\mathbf{n}_j = n_j - i k_j$ .

16 (original) The computer-readable medium of claim 15 wherein instruction (a) further includes the instruction of: providing the ambient and substrate with complex indexes of refraction:  $\mathbf{n}_0 = n_0 - i k_0$  and  $\mathbf{n}_{N+1} = n_{N+1} - i k_{N+1}$ , respectively.

17 (original) The computer-readable medium of claim 16 wherein instruction (a) further includes the instruction of: defining reflectivity at an interface between two layers as a cost function, wherein the reflectivity  $R_j$  at a  $j^{\text{th}}$  interface (between the  $(j-1)^{\text{th}}$  and  $j^{\text{th}}$  layers) is a function of  $3(N-j+1) + 4$  parameters, which are ;  $n_{j-1}$ ,  $n_j \dots n_N$ ,  $n_{N+1}$ ;  $k_{j-1}$ ,  $k_j \dots k_N$ ,  $k_{N+1}$ ;  $d_j$ ,  $d_{j+1} \dots d_N$ .

18 (currently amended) The computer-readable medium of claim 11 wherein instruction (b) further includes the instruction of: allowing the user to enter values for the thickness and the complex indexes of refraction ( $n$  and  $k$ ) for each layer, including a current starting point, a minimum values, and a maximum value for the thickness and the complex indexes of refraction for each layer.

19 (currently amended) The computer-readable medium of claim 18 wherein instruction (b) further includes the instruction of: allowing the user to ~~choose which of the parameters will be independent variables and to enter instruction step values for the parameters designated as independent variables~~, wherein those parameters that are not designated as varying independent variables are fixed.

20 (original) The computer-readable medium of claim 11 wherein instruction (e) further includes the instruction of: defining the sensitivity as  $S = (\text{Max } R - \text{Min } R)$  for all varied parameters.